

1. Record Nr.	UNINA9910789057803321
Titolo	Orthopedic residency & fellowship : a guide to success // [edited by] Laith M. Jazrawi, Kenneth A. Egol, Joseph D. Zuckerman
Pubbl/distr/stampa	Thorofare, NJ : , : SLACK Incorporated, , [2010] ©2010
ISBN	1-61711-746-3
Descrizione fisica	1 online resource (260 p.)
Altri autori (Persone)	JazrawiLaith M. <1969-> EgolKenneth A. <1967-> ZuckermanJoseph D <1952-> (Joseph David)
Disciplina	616.7
Soggetti	Orthopedics - Study and teaching (Residency) - United States
Lingua di pubblicazione	Inglese
Formato	Materiale a stampa
Livello bibliografico	Monografia
Note generali	Description based upon print version of record.
Nota di bibliografia	Includes bibliographical references.
Nota di contenuto	Evaluation of the applicant / Kenneth A. Egol -- Medical school : the early years / Lava Y. Patel and David E. Ruchelsman -- Medical school : clinical clerkships and electives / Lava Y. Patel and Eric J. Strauss -- The application process / Crispin C. Ong and David E. Ruchelsman -- Letters of recommendation / Laith M. Jazrawi -- Resident selection interviews / Kenneth A. Egol -- Choosing a residency program : the match / Daniel M. Lerman and David E. Ruchelsman -- International medical graduates / Lava Y. Patel and Carl Paulino -- What to do if you don't match / Joseph D. Zuckerman -- Internship / Kirk A. Campbell and Eric J. Strauss -- Residency survival skills : keys to success / Eric J. Strauss and David E. Ruchelsman -- Program and institutional requirements / Joseph D. Zuckerman -- Women in orthopedic surgery / Suzie Kim and Catherine Laible -- The orthopaedic in-training exam / Eric J. Strauss and David E. Ruchelsman -- Research during your residency / Eric J. Strauss and David E. Ruchelsman -- Finances during your residency / Lawrence B. Keller -- Fellowships : getting a position and succeeding / Laith M. Jazrawi ... [et al.] -- Job search : what to look for in a potential position / Laith M. Jazrawi -- Reviewing physician employment contracts / Andrew E. Blustein -- The boards / Kenneth A. Egol, Laith M. Jazrawi, and Joseph D. Zuckerman.

